Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/809,960	OLSCHEWSKI ET AL.	OLSCHEWSKI ET AL.	
Examiner	Art Unit		
Dennis Rosario	2624		

SEARCHED					
Class	Subclass	Date	Examiner		
	103,128	4/12/07	DR		
382	133,287	4/12/07			
	284,294	•	9		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East, all dB	4/12/07	DR		
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IEEE- Microscope and vector inens	4/4/07	DR		
(motion or velocity)-				
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